

<b>Notice of References Cited</b>	Application/Control No. 10/574,392		Applicant(s)/Patent Under Reexamination YU ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0018525	01-2004	Wirtz et al.	435/6
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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#### FOREIGN PATENT DOCUMENTS

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#### NON-PATENT DOCUMENTS

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